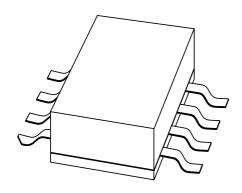
## **DISCRETE SEMICONDUCTORS**

## DATA SHEET



# **BLF404**UHF power MOS transistor

Product specification Supersedes data of 1998 Jan 29 2003 Sep 26





## **UHF power MOS transistor**

## **BLF404**

#### **FEATURES**

- · High power gain
- · Easy power control
- · Gold metallization
- · Good thermal stability
- · Withstands full load mismatch
- Designed for broadband operation.

#### **APPLICATIONS**

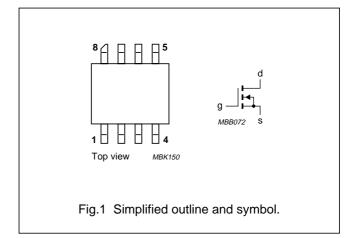
• Communication transmitters in the VHF/UHF range with a nominal supply voltage of 12.5 V.

#### **DESCRIPTION**

Silicon N-channel enhancement mode vertical D-MOS power transistor in an 8-lead SOT409A SMD package with a ceramic cap.

#### **PINNING - SOT409A**

PIN	DESCRIPTION
1, 8	source
2, 3	gate
4, 5	source
6, 7	drain



#### **QUICK REFERENCE DATA**

RF performance at  $T_{mb} \le 60$  °C in a common source test circuit.

MODE OF OPERATION	f	V <sub>DS</sub>	P <sub>L</sub>	G <sub>p</sub>	η <sub>D</sub>
	(MHz)	(V)	(W)	(dB)	(%)
CW class-AB	500	12.5	4	≥10	≥50

#### **CAUTION**

This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling. For further information, refer to Philips specs.: SNW-EQ-608, SNW-FQ-302A, and SNW-FQ-302B.

## UHF power MOS transistor

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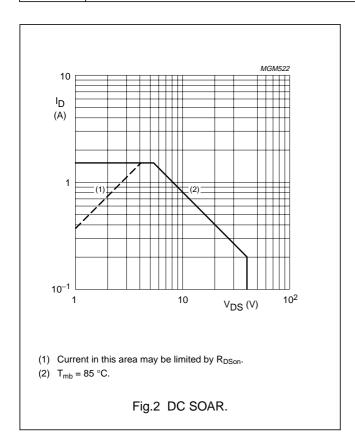
## LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	PARAMETER CONDITIONS			UNIT
V <sub>DS</sub>	drain-source voltage		_	40	V
$V_{GS}$	gate-source voltage		_	±20	V
$I_D$	drain current (DC)		_	1.5	Α
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> ≤ 85 °C	_	8.3	W
T <sub>stg</sub>	storage temperature		-65	+150	°C
Tj	junction temperature		_	200	°C

## THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R <sub>th j-mb</sub>	thermal resistance from junction to mounting base	$T_{mb} \le 85  ^{\circ}C$ , $P_{tot} = 8.3  W$	12.1	K/W



## UHF power MOS transistor

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## **CHARACTERISTICS**

 $T_j = 25$  °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	$V_{GS} = 0; I_D = 5 \text{ mA}$	40	_	_	V
$V_{GSth}$	gate-source threshold voltage	$I_D = 50 \text{ mA}; V_{DS} = 10 \text{ V}$	2	_	4.5	V
I <sub>DSS</sub>	drain-source leakage current	V <sub>GS</sub> = 0; V <sub>DS</sub> = 12.5 V	_	_	0.5	mA
I <sub>GSS</sub>	gate-source leakage current $V_{GS} = \pm 20 \text{ V}; V_{DS} = 0$		_	_	1	μΑ
I <sub>DSX</sub>	on-state drain current	$V_{GS} = 15 \text{ V}; V_{DS} = 10 \text{ V}$		2.3	_	Α
R <sub>DSon</sub>	drain-source on-state resistance	$I_D = 0.7 A; V_{GS} = 15 V$	_	1.8	2.7	Ω
g <sub>fs</sub>	forward transconductance	$I_D = 0.7 \text{ A}; V_{DS} = 10 \text{ V}$	200	270	_	mS
C <sub>is</sub>	input capacitance	$V_{GS} = 0$ ; $V_{DS} = 12.5 \text{ V}$ ; $f = 1 \text{ MHz}$	_	14	_	pF
C <sub>os</sub>	output capacitance	$V_{GS} = 0$ ; $V_{DS} = 12.5 \text{ V}$ ; $f = 1 \text{ MHz}$	_	17	_	pF
C <sub>rs</sub>	feedback capacitance	$V_{GS} = 0$ ; $V_{DS} = 12.5 \text{ V}$ ; $f = 1 \text{ MHz}$	_	3	_	pF

## $V_{\text{GS}}$ group indicator

GROUP		IITS V)	GROUP	<b>I</b>	MITS V)
	MIN.	MAX.		MIN.	MAX.
А	2.0	2.1	0	3.3	3.4
В	2.1	2.2	Р	3.4	3.5
С	2.2	2.3	Q	3.5	3.6
D	2.3	2.4	R	3.6	3.7
Е	2.4	2.5	S	3.7	3.8
F	2.5	2.6	Т	3.8	3.9
G	2.6	2.7	U	3.9	4.0
Н	2.7	2.8	V	4.0	4.1
J	2.8	2.9	W	4.1	4.2
K	2.9	3.0	X	4.2	4.3
L	3.0	3.1	Y	4.3	4.4
М	3.1	3.2	Z	4.4	4.5
N	3.2	3.3			

## UHF power MOS transistor

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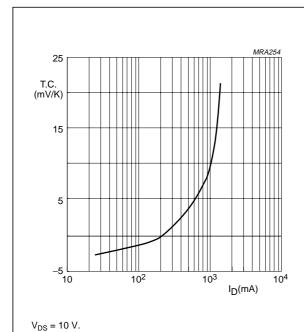
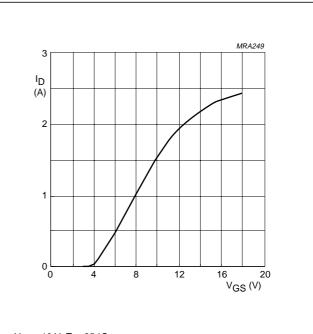


Fig.3 Temperature coefficient of gate-source voltage as a function of drain current; typical values.



 $V_{DS}$  = 10 V;  $T_j$  = 25 °C.

Fig.4 Drain current as a function of gate-source voltage; typical values.

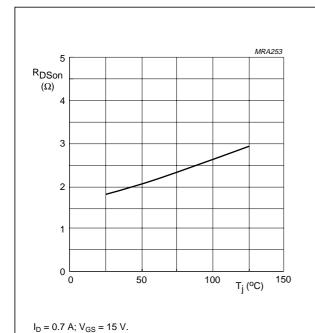
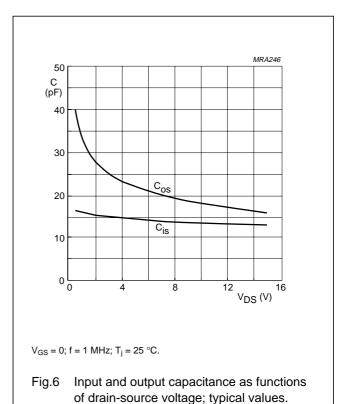


Fig.5 Drain-source on-state resistance as a function of junction temperature; typical values.

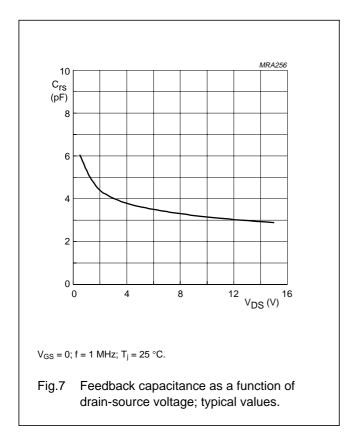


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## UHF power MOS transistor

**BLF404** 



#### **APPLICATION INFORMATION**

RF performance at  $T_{mb} \le 60$  °C in a common source test circuit with the device soldered on a printed-circuit board with through metallized holes.

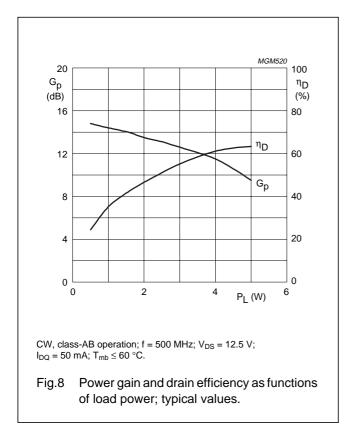
MODE OF OPERATION	f (MHz)	V <sub>DS</sub> (V)	I <sub>DQ</sub> (A)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	η <sub>D</sub> (%)
CW, class-AB	500	12.5	50	4	≥10	≥50
					typ. 11.5	typ. 55

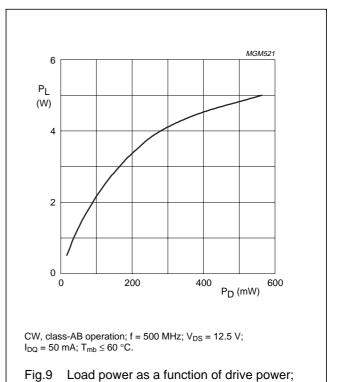
## Ruggedness in class-AB operation

The BLF404 is capable of withstanding a load mismatch corresponding to VSWR = 10 : 1 through all phases under the following conditions: f = 500 MHz;  $V_{DS} = 12.5$  V;  $P_L = 4$  W;  $T_{mb} \le 60$  °C.

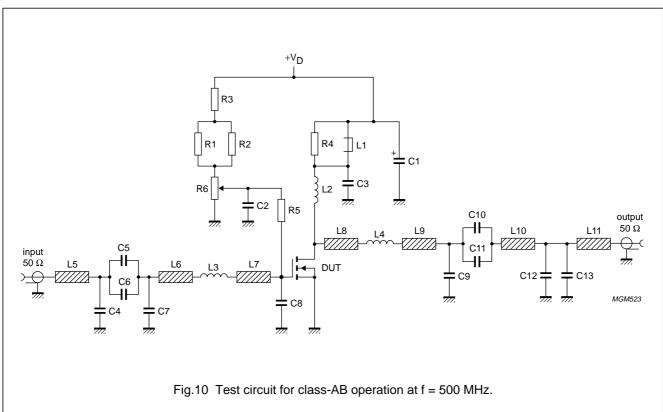
## UHF power MOS transistor

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typical values.



## UHF power MOS transistor

**BLF404** 

List of components; see Figs 10 and 11.

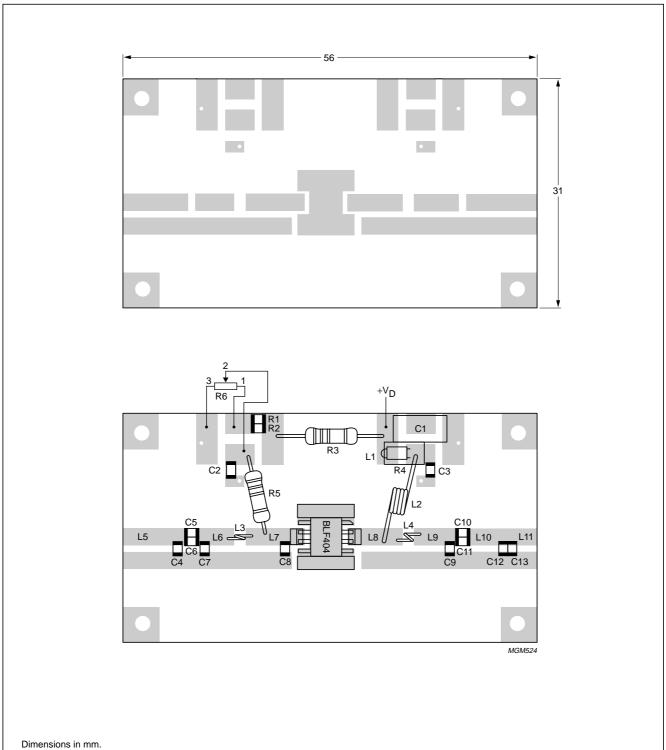
COMPONENT	DESCRIPTION	VALUE	DIMENSIONS	CATALOGUE NO.
C1	electrolytic capacitor	4.7 μF, 10 V		
C2, C3	multilayer ceramic chip capacitor	47 nF		
C4	multilayer ceramic chip capacitor; note 1	18 pF		
C5, C10	multilayer ceramic chip capacitor; note 1	180 pF		
C6, C11	multilayer ceramic chip capacitor; note 1	270 pF		
C7	multilayer ceramic chip capacitor; note 1	22 pF		
C8	multilayer ceramic chip capacitor; note 1	8.2 pF		
C9	multilayer ceramic chip capacitor; note 1	2.7 pF		
C12	multilayer ceramic chip capacitor; note 1	1.2 pF		
C13	multilayer ceramic chip capacitor; note 1	12 pF		
L1	2 turns 1 mm enamelled copper wire on a grade 4B1 Ferroxcube core		ext. dia. = 4.2 mm int. dia. = 2 mm length = 6 mm	
L2	3 turns 1 mm enamelled copper wire		int. dia. = 4.6 mm leads = 2 x 5 mm	
L3	bifilar coil		lead dia. = 0.8 mm	
L4	bifilar coil		lead dia. = 1 mm	
L5	stripline; note 2	50 Ω	8.8 × 2.38 mm	
L6	stripline; note 2	50 Ω	5.8 × 2.38 mm	
L7	stripline; note 2	50 Ω	6.8 × 2.38 mm	
L8	stripline; note 2	50 Ω	3.76 × 2.38 mm	
L9	stripline; note 2	50 Ω	5.8 × 2.38 mm	
L10	stripline; note 2	50 Ω	4.48 × 2.38 mm	
L11	stripline; note 2	50 Ω	3.13 × 2.38 mm	
R1, R2	SMD resistor	3.9 kΩ		
R3	metal film resistor	1 kΩ, 0.25 W		
R4	metal film resistor	22 Ω, 0.25 W		
R5	metal film resistor	10 kΩ, 0.25 W		
R6	potentiometer	10 kΩ		

#### **Notes**

- 1. American Technical Ceramics type 100A or capacitor of same quality.
- 2. The striplines are on a double copper-clad printed-circuit board, with DUROID dielectric ( $\epsilon_r$  = 2.2); thickness 0.79 mm, thickness of the copper sheet 2 x 35  $\mu$ m.

## UHF power MOS transistor

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The components are situated on one side of the copper-clad printed-circuit board, the other side is unetched and serves as a ground plane. Earth connections from the component side to the ground plane are made by through metallization.

Fig.11 Component layout for 500 MHz class-AB test circuit.

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## UHF power MOS transistor

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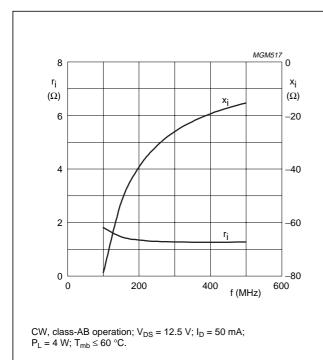


Fig.12 Input impedance as a function of frequency (series components); typical values.

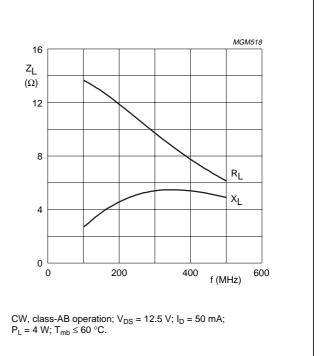
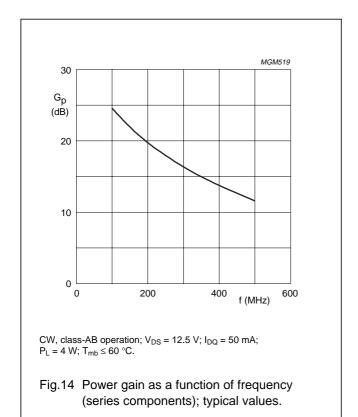


Fig.13 Load impedance as a function of frequency (series components); typical values.



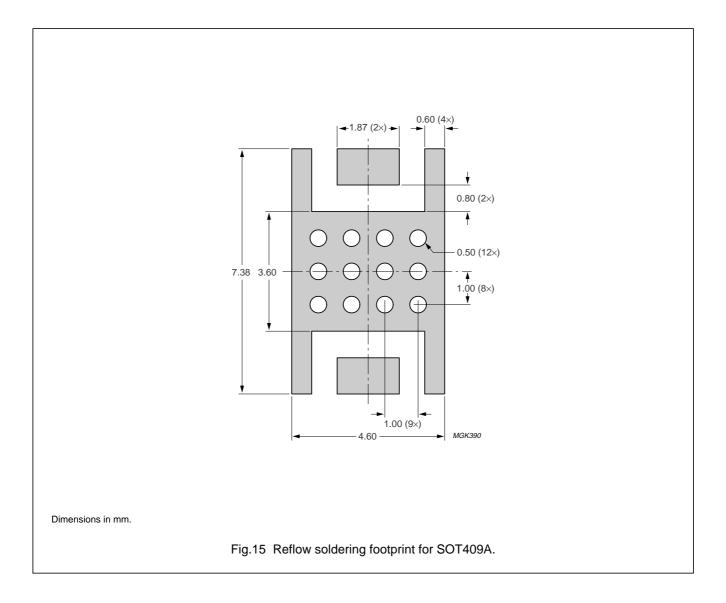
## **UHF** power MOS transistor

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#### MOUNTING RECOMMENDATIONS

Both the metallized ground plate and the device leads contribute to the heat flow. It is recommended that the transistor be mounted on a grounded metallized area of the printed-circuit board. This area should be of maximum 0.8 mm thickness and include at least 12 x 0.5 diameter through metallized holes filled with solder.

A thermal resistance  $R_{th(mb-h)}$  of 5 K/W can be achieved if heatsink compound is applied when the transistor is mounted on the printed-circuit board.



## UHF power MOS transistor

**BLF404** 

## **BLF404** scattering parameters

 $V_{DS} = 12.5 \text{ V}; I_D = 50 \text{ mA}; \text{ note } 1.$ 

f (MHz)		S <sub>11</sub>	S	21	S <sub>1</sub>	2	s <sub>22</sub>		
( V	s <sub>11</sub>	∠Φ	s <sub>21</sub>	∠Φ	s <sub>12</sub>	∠Φ	s <sub>22</sub>	∠Φ	
5	1.00	-5.2	12.97	176.0	0.01	86.0	0.96	-6.0	
10	0.99	-10.1	12.89	171.9	0.02	82.2	0.96	-12.0	
20	0.98	-20.6	12.61	164.1	0.03	74.8	0.95	-23.5	
30	0.96	-30.4	12.18	156.6	0.05	67.6	0.93	-34.7	
40	0.93	-39.6	11.62	149.6	0.06	60.9	0.91	-45.1	
50	0.89	-48.0	11.00	143.2	0.07	54.8	0.89	-54.7	
60	0.86	-55.8	10.37	137.4	0.08	49.4	0.87	-63.5	
70	0.83	-62.9	9.74	132.2	0.09	44.4	0.85	-71.4	
80	0.80	-69.4	9.15	127.5	0.10	40.1	0.83	-78.5	
90	0.78	-75.3	8.60	123.2	0.10	36.2	0.82	-84.8	
100	0.75	-80.7	8.08	119.3	0.10	32.7	0.80	-90.5	
125	0.71	-92.2	6.96	110.7	0.11	25.1	0.77	-102.6	
150	0.68	-101.4	6.03	103.9	0.12	19.1	0.76	-111.9	
175	0.66	-108.9	5.30	98.3	0.12	14.4	0.74	-119.2	
200	0.64	-115.2	4.73	93.2	0.12	10.2	0.74	-125.1	
250	0.63	-124.9	3.81	84.5	0.12	3.5	0.73	-134.1	
300	0.64	-132.5	3.19	77.4	0.12	-1.8	0.74	-140.5	
350	0.64	-138.6	2.70	71.2	0.11	-6.1	0.74	-145.3	
400	0.66	-143.8	2.34	65.7	0.11	-9.7	0.75	-149.1	
450	0.67	-148.4	2.03	60.5	0.10	-12.5	0.76	-152.4	
500	0.69	-152.6	1.80	56.0	0.09	-15.1	0.78	-155.2	
600	0.72	-160.2	1.44	47.7	0.08	-18.2	0.80	-159.9	
700	0.75	-167.1	1.18	40.4	0.07	-18.6	0.82	-163.9	
800	0.78	-173.6	0.99	34.4	0.05	-15.0	0.84	-167.5	
900	0.81	-179.8	0.84	29.2	0.04	-6.0	0.86	-170.7	
1000	0.83	174.3	0.73	25.1	0.04	9.9	0.88	-173.6	

## Note

<sup>1.</sup> For more extensive s-parameters see internet: http://www.semiconductors.philips.com/markets/communications/wirelesscommunications/broadcast

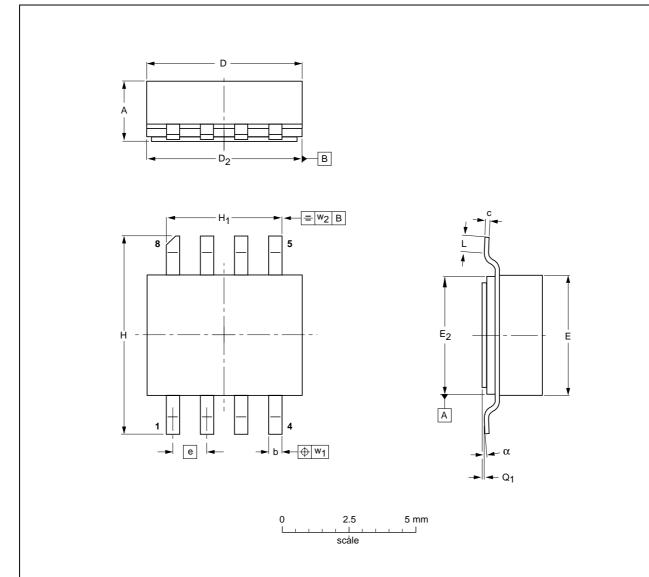
## UHF power MOS transistor

**BLF404** 

## **PACKAGE OUTLINE**

Ceramic surface mounted package; 8 leads

SOT409A



## DIMENSIONS (millimetre dimensions are derived from the original inch dimensions)

UNIT	A	b	С	D	D <sub>2</sub>	E	E <sub>2</sub>	е	н	Н1	L	Q <sub>1</sub>	w <sub>1</sub>	w <sub>2</sub>	α
mm	2.36 2.06	0.58 0.43	0.23 0.18	5.94 5.03	5.16 5.00	4.93 4.01	4.14 3.99	1.27	7.47 7.26	4.39 4.24	1.02 0.51	0.10 0.00	0.25	0.25	7° 0°
inches	0.093 0.081	0.023 0.017	0.009 0.007	0.234 0.198	0.203 0.197	0.194 0.158	0.163 0.157	0.050	0.294 0.286	0.173 0.167	0.040 0.020	0.004 0.000	0.010	0.010	7° 0°

OUTLINE		REFER	EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT409A						98-01-27

## **UHF** power MOS transistor

**BLF404** 

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Printed in The Netherlands

613524/04/pp15

Date of release: 2003 Sep 26

Document order number: 9397 750 11603

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